

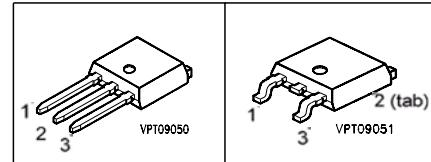
## Cool MOS™ Power Transistor

### Feature

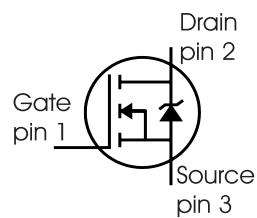
- New revolutionary high voltage technology
- Ultra low gate charge
- Periodic avalanche rated
- Extreme dv/dt rated
- Ultra low effective capacitances
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>0)</sup> for target applications

$V_{DS}$ @ $T_{jmax}$	650	V
$R_{DS(on)}$	3	$\Omega$
$I_D$	1.8	A

PG-T0251                    PG-T0252



Type	Package	Ordering Code	Marking
SPD02N60C3	PG-T0252	Q67040-S4420	02N60C3
SPU02N60C3	PG-T0251		02N60C3



### Maximum Ratings

Parameter	Symbol	Value	Unit
Continuous drain current $T_C = 25^\circ\text{C}$	$I_D$	1.8	A
$T_C = 100^\circ\text{C}$		1.1	
Pulsed drain current, $t_p$ limited by $T_{jmax}$	$I_{D \text{ puls}}$	5.4	
Avalanche energy, single pulse $I_D = 1.35 \text{ A}, V_{DD} = 50 \text{ V}$	$E_{AS}$	50	mJ
Avalanche energy, repetitive $t_{AR}$ limited by $T_{jmax}$ <sup>1)</sup> $I_D = 1.8 \text{ A}, V_{DD} = 50 \text{ V}$	$E_{AR}$	0.07	
Avalanche current, repetitive $t_{AR}$ limited by $T_{jmax}$	$I_{AR}$	1.8	A
Gate source voltage static	$V_{GS}$	$\pm 20$	V
Gate source voltage AC ( $f > 1\text{Hz}$ )	$V_{GS}$	$\pm 30$	
Power dissipation, $T_C = 25^\circ\text{C}$	$P_{tot}$	25	W
Operating and storage temperature	$T_j, T_{stg}$	-55... +150	°C
Reverse diode dv/dt <sup>5)</sup>	dv/dt	15	V/ns

### Maximum Ratings

Parameter	Symbol	Value	Unit
Drain Source voltage slope $V_{DS} = 480 \text{ V}$ , $I_D = 1.8 \text{ A}$ , $T_j = 125^\circ\text{C}$	$dv/dt$	50	V/ns

### Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Thermal resistance, junction - case	$R_{thJC}$	-	-	5	K/W
Thermal resistance, junction - ambient, leaded	$R_{thJA}$	-	-	75	
SMD version, device on PCB: @ min. footprint @ 6 cm <sup>2</sup> cooling area <sup>2)</sup>	$R_{thJA}$	-	-	75	
Soldering temperature, *) 1.6 mm (0.063 in.) from case for 10s	$T_{sold}$	-	-	260	°C

### Electrical Characteristics, at $T_j=25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{V}$ , $I_D=0.25\text{mA}$	600	-	-	V
Drain-Source avalanche breakdown voltage	$V_{(BR)DS}$	$V_{GS}=0\text{V}$ , $I_D=0.25\text{A}$	-	700	-	
Gate threshold voltage	$V_{GS(th)}$	$I_D=80\mu\text{A}$ , $V_{GS}=V_{DS}$	2.1	3	3.9	$\mu\text{A}$
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=600\text{V}$ , $V_{GS}=0\text{V}$ , $T_j=25^\circ\text{C}$ , $T_j=150^\circ\text{C}$	-	0.5	1	
Gate-source leakage current	$I_{GSS}$	$V_{GS}=30\text{V}$ , $V_{DS}=0\text{V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{V}$ , $I_D=1.1\text{A}$ , $T_j=25^\circ\text{C}$ $T_j=150^\circ\text{C}$	-	2.7	3	$\Omega$
Gate input resistance	$R_G$	f=1MHz, open Drain	-	7.3	-	
			-	9	-	

\*) TO252: reflow soldering, MSL3; TO251: wavesoldering

**Electrical Characteristics , at  $T_j = 25^\circ\text{C}$ , unless otherwise specified**

<b>Parameter</b>	<b>Symbol</b>	<b>Conditions</b>	<b>Values</b>			<b>Unit</b>
			<b>min.</b>	<b>typ.</b>	<b>max.</b>	
Transconductance	$g_{fs}$	$V_{DS} \geq 2 * I_D * R_{DS(on)max}$ , $I_D = 1.1\text{A}$	-	1.75	-	S
Input capacitance	$C_{iss}$	$V_{GS} = 0\text{V}$ , $V_{DS} = 25\text{V}$ , $f = 1\text{MHz}$	-	200	-	pF
Output capacitance	$C_{oss}$		-	90	-	
Reverse transfer capacitance	$C_{rss}$		-	4	-	
Effective output capacitance, <sup>3)</sup> energy related	$C_{o(er)}$	$V_{GS} = 0\text{V}$ , $V_{DS} = 0\text{V to } 480\text{V}$	-	8.1	-	pF
Effective output capacitance, <sup>4)</sup> time related	$C_{o(tr)}$		-	15.7	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 350\text{V}$ , $V_{GS} = 0/10\text{V}$ , $I_D = 1.8\text{A}$ , $R_G = 25\Omega$	-	6	-	ns
Rise time	$t_r$		-	3	-	
Turn-off delay time	$t_{d(off)}$		-	68	70	
Fall time	$t_f$		-	12	30	

**Gate Charge Characteristics**

Gate to source charge	$Q_{gs}$	$V_{DD} = 420\text{V}$ , $I_D = 1.8\text{A}$	-	1.6	-	nC
Gate to drain charge	$Q_{gd}$		-	3.8	-	
Gate charge total	$Q_g$	$V_{DD} = 420\text{V}$ , $I_D = 1.8\text{A}$ , $V_{GS} = 0$ to $10\text{V}$	-	9.5	12.5	
Gate plateau voltage	$V_{(plateau)}$	$V_{DD} = 420\text{V}$ , $I_D = 1.8\text{A}$	-	5.5	-	V

<sup>0</sup>J-STD20 and JESD22

<sup>1</sup>Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV} = E_{AR} * f$ .

<sup>2</sup>Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.

<sup>3</sup> $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>4</sup> $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>5</sup> $|I_{SD}| \leq I_D$ ,  $di/dt \leq 400\text{A/us}$ ,  $V_{DClink} = 400\text{V}$ ,  $V_{peak} < V_{BR, DSS}$ ,  $T_j < T_{j,max}$ .

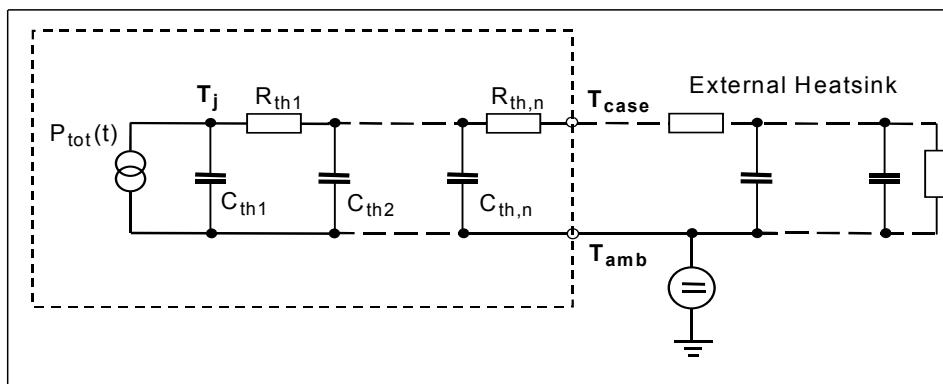
Identical low-side and high-side switch.

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Inverse diode continuous forward current	$I_S$	$T_C=25^\circ\text{C}$	-	-	1.8	A
Inverse diode direct current, pulsed	$I_{SM}$		-	-	5.4	
Inverse diode forward voltage	$V_{SD}$	$V_{GS}=0\text{V}$ , $I_F=I_S$	-	1	1.2	V
Reverse recovery time	$t_{rr}$	$V_R=420\text{V}$ , $I_F=I_S$ , $dI_F/dt=100\text{A}/\mu\text{s}$	-	200	350	ns
Reverse recovery charge	$Q_{rr}$		-	1.3	-	$\mu\text{C}$
Peak reverse recovery current	$I_{rrm}$		-	9	-	A
Peak rate of fall of reverse recovery current	$dI_{rr}/dt$		-	-	200	$\text{A}/\mu\text{s}$

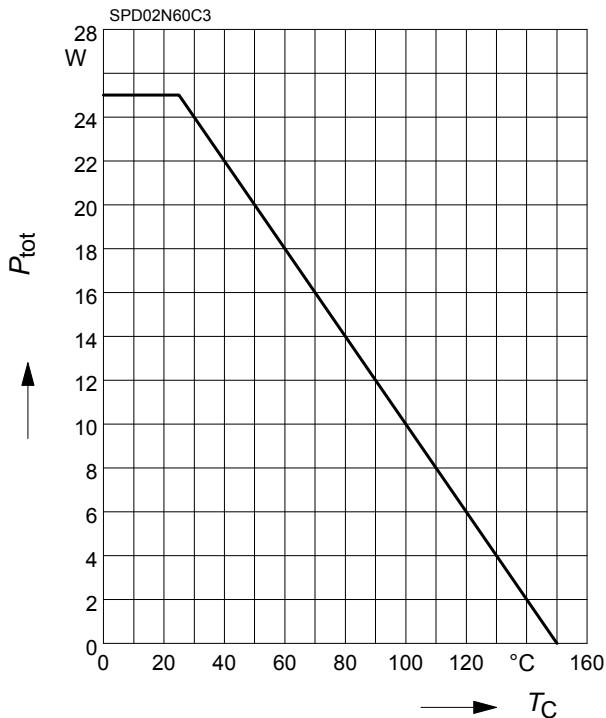
**Typical Transient Thermal Characteristics**

Symbol	Value	Unit	Symbol	Value	Unit
Thermal resistance			Thermal capacitance		
$R_{th1}$	0.1	K/W	$C_{th1}$	0.00002806	Ws/K
$R_{th2}$	0.184		$C_{th2}$	0.0001113	
$R_{th3}$	0.306		$C_{th3}$	0.0001679	
$R_{th4}$	1.207		$C_{th4}$	0.000547	
$R_{th5}$	0.974		$C_{th5}$	0.001388	
$R_{th6}$	0.251		$C_{th6}$	0.019	



### 1 Power dissipation

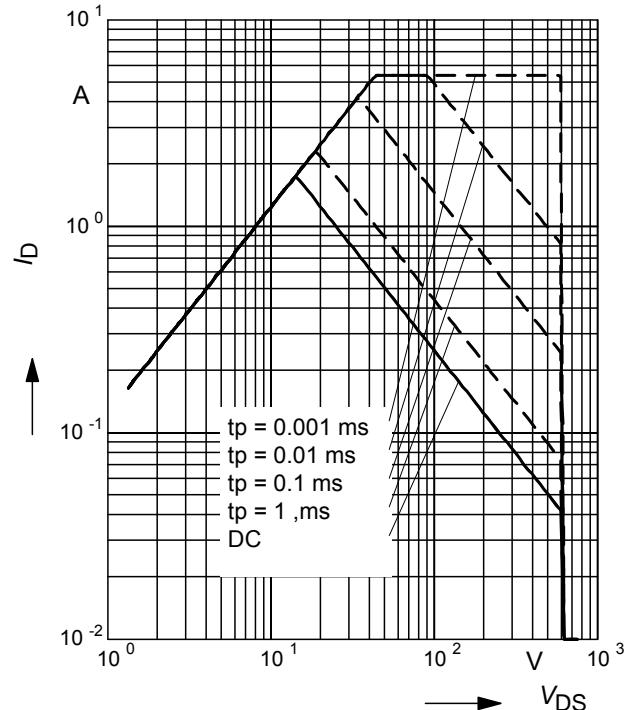
$$P_{\text{tot}} = f(T_C)$$



### 2 Safe operating area

$$I_D = f(V_{DS})$$

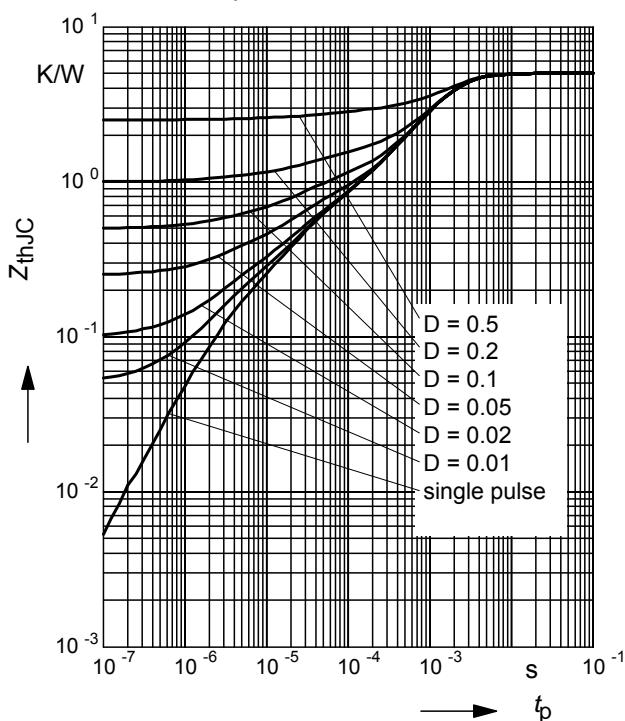
parameter :  $D = 0$ ,  $T_C = 25^\circ\text{C}$



### 3 Transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

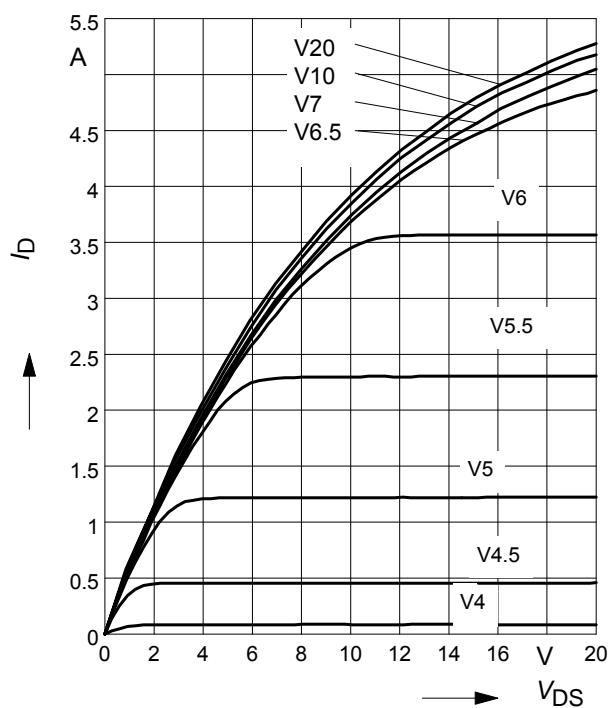
parameter:  $D = t_p/T$



### 4 Typ. output characteristic

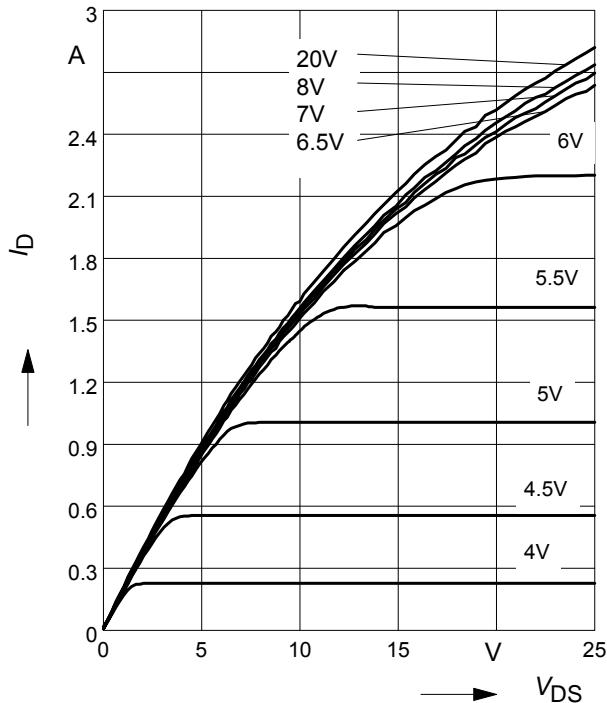
$$I_D = f(V_{DS}); \quad T_j = 25^\circ\text{C}$$

parameter:  $t_p = 10 \mu\text{s}$ ,  $V_{GS}$



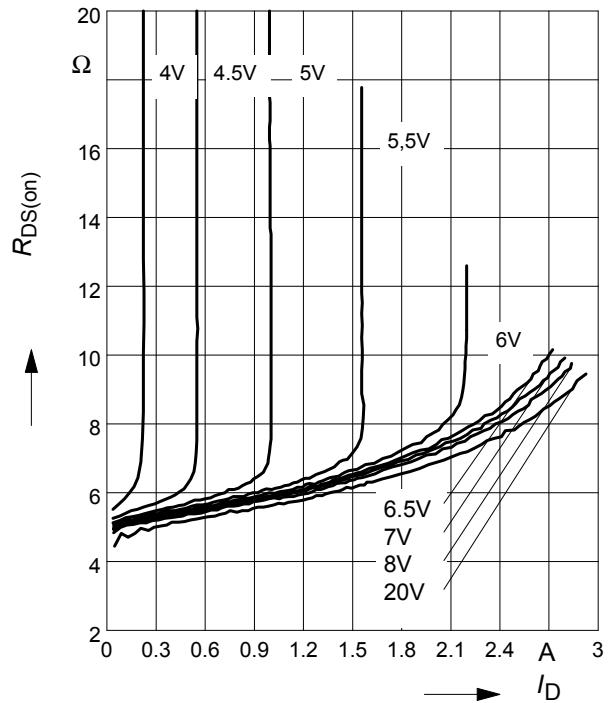
### 5 Typ. output characteristic

$I_D = f(V_{DS})$ ;  $T_j=150^\circ\text{C}$   
parameter:  $t_p = 10 \mu\text{s}$ ,  $V_{GS}$



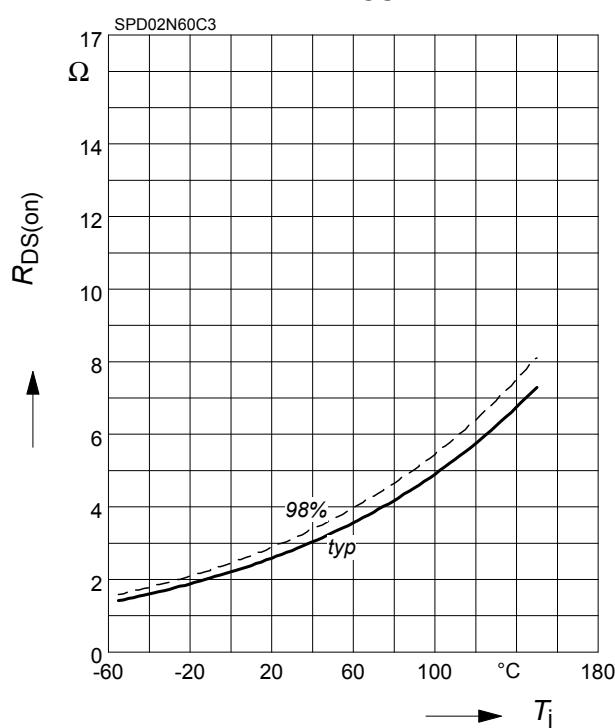
### 6 Typ. drain-source on resistance

$R_{DS(on)}=f(I_D)$   
parameter:  $T_j=150^\circ\text{C}$ ,  $V_{GS}$



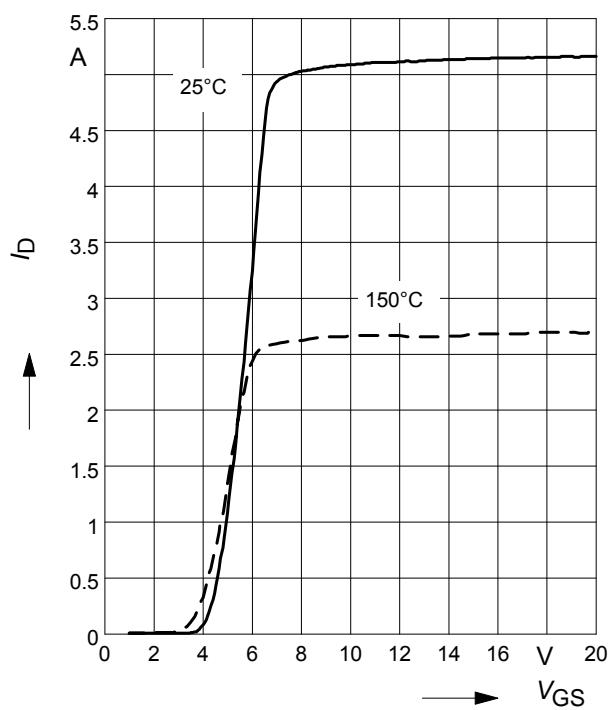
### 7 Drain-source on-state resistance

$R_{DS(on)}=f(T_j)$   
parameter :  $I_D = 1.1 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$



### 8 Typ. transfer characteristics

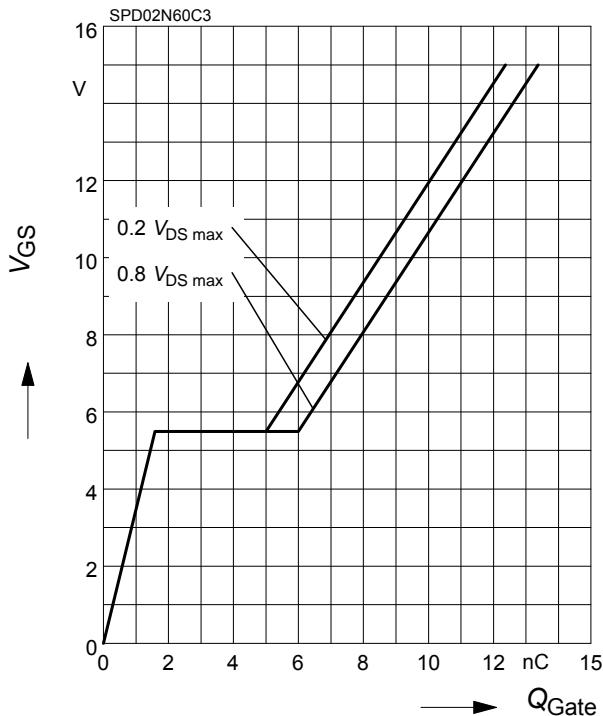
$I_D = f( V_{GS} )$ ;  $V_{DS} \geq 2 \times I_D \times R_{DS(on)\max}$   
parameter:  $t_p = 10 \mu\text{s}$



### 9 Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

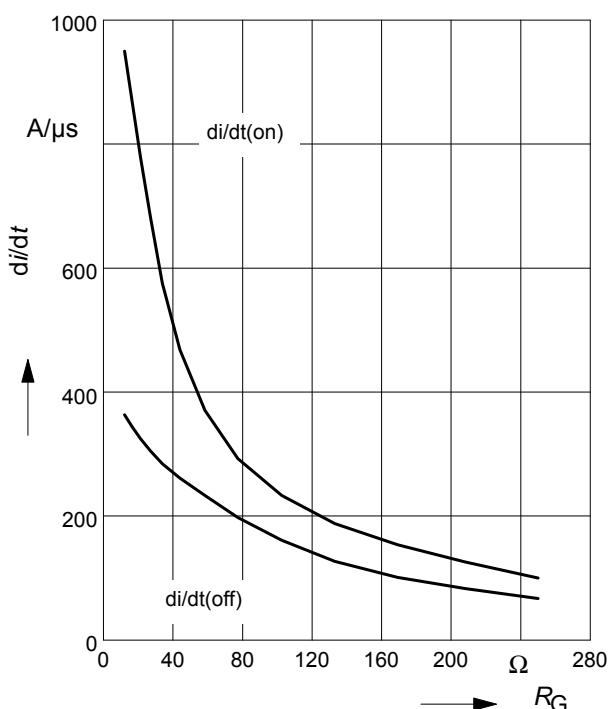
parameter:  $I_D = 1.8 \text{ A pulsed}$



### 11 Typ. drain current slope

$dI/dt = f(R_G)$ , inductive load,  $T_j = 125^\circ\text{C}$

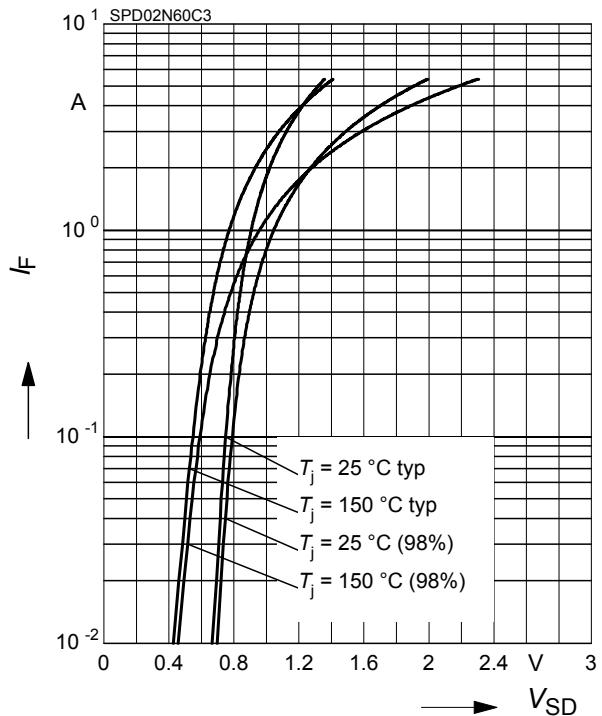
par.:  $V_{DS}=380\text{V}$ ,  $V_{GS}=0/+13\text{V}$ ,  $I_D=1.8\text{A}$



### 10 Forward characteristics of body diode

$$I_F = f(V_{SD})$$

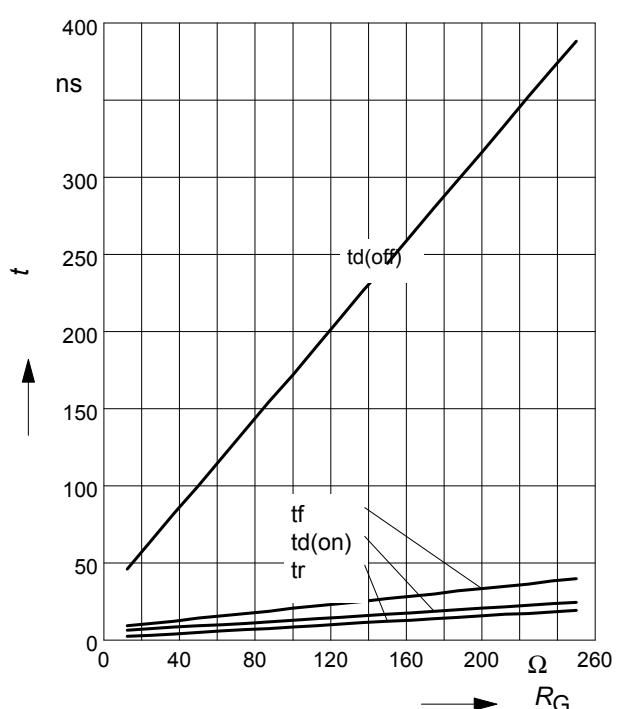
parameter:  $T_j$ ,  $t_p = 10 \mu\text{s}$



### 12 Typ. switching time

$t = f(R_G)$ , inductive load,  $T_j=125^\circ\text{C}$

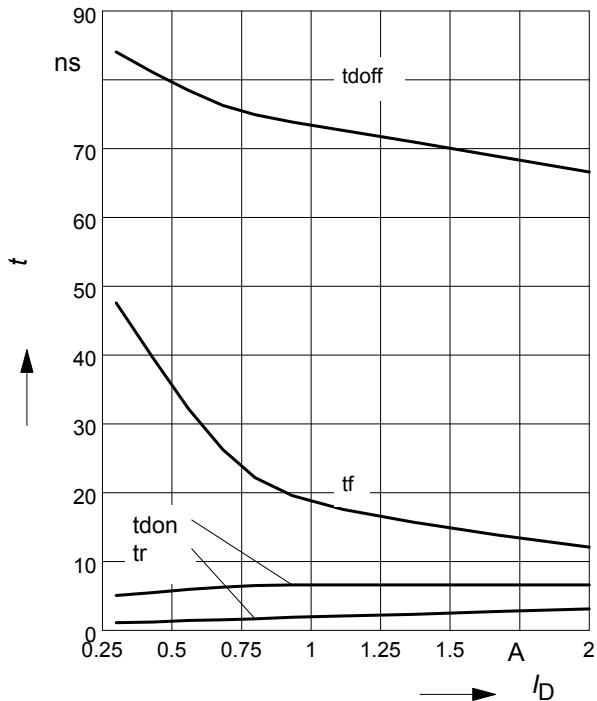
par.:  $V_{DS}=380\text{V}$ ,  $V_{GS}=0/+13\text{V}$ ,  $I_D=1.8\text{ A}$



### 13 Typ. switching time

$t = f(I_D)$ , inductive load,  $T_j = 125^\circ\text{C}$

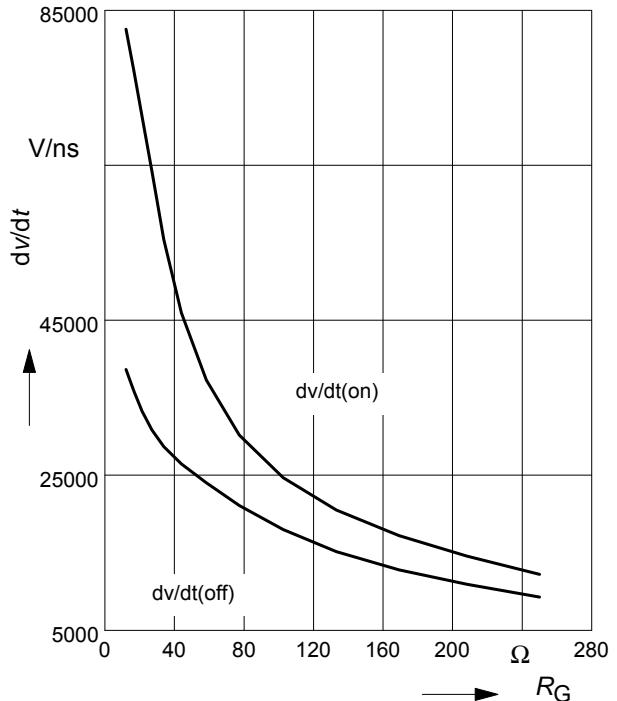
par.:  $V_{DS} = 380\text{V}$ ,  $V_{GS} = 0/+13\text{V}$ ,  $R_G = 25\Omega$



### 14 Typ. drain source voltage slope

$dv/dt = f(R_G)$ , inductive load,  $T_j = 125^\circ\text{C}$

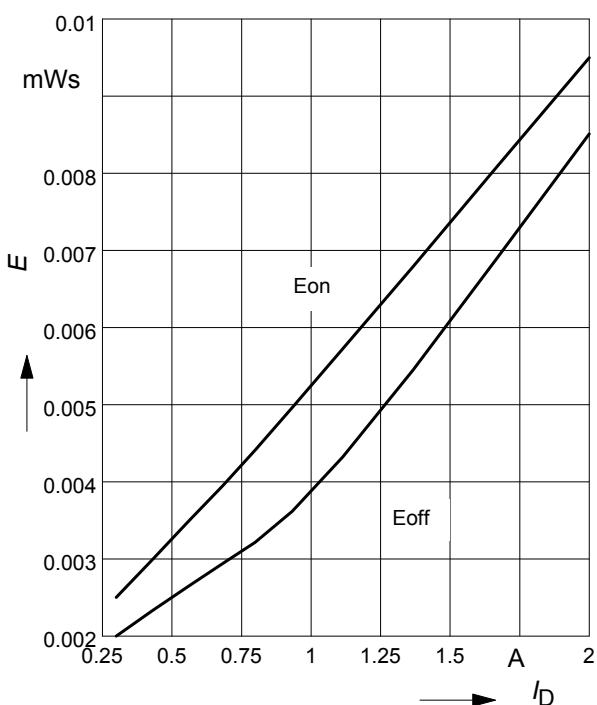
par.:  $V_{DS} = 380\text{V}$ ,  $V_{GS} = 0/+13\text{V}$ ,  $I_D = 1.8\text{A}$



### 15 Typ. switching losses

$E = f(I_D)$ , inductive load,  $T_j = 125^\circ\text{C}$

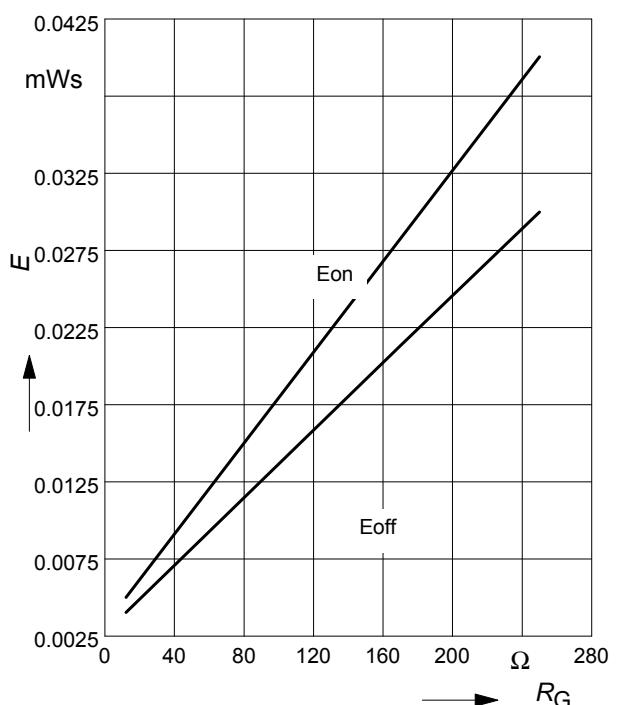
par.:  $V_{DS} = 380\text{V}$ ,  $V_{GS} = 0/+13\text{V}$ ,  $R_G = 25\Omega$



### 16 Typ. switching losses

$E = f(R_G)$ , inductive load,  $T_j = 125^\circ\text{C}$

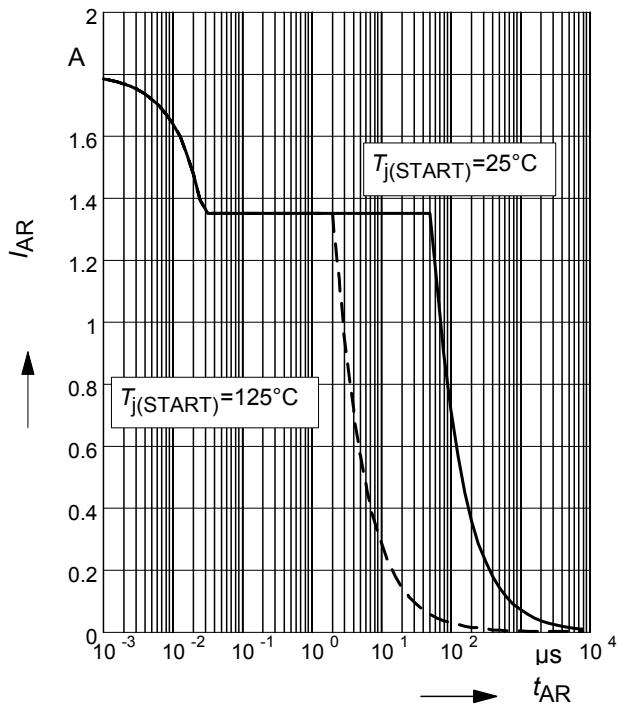
par.:  $V_{DS} = 380\text{V}$ ,  $V_{GS} = 0/+13\text{V}$ ,  $I_D = 1.8\text{A}$



### 17 Avalanche SOA

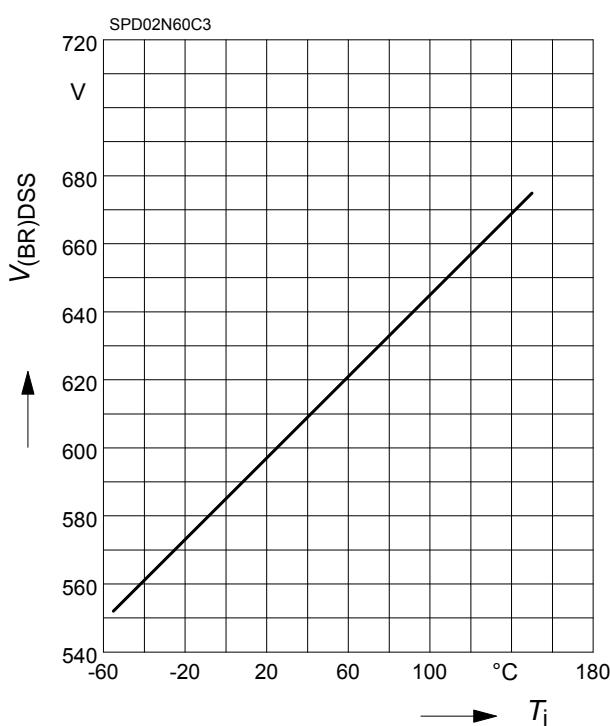
$$I_{AR} = f(t_{AR})$$

par.:  $T_j \leq 150^\circ\text{C}$



### 19 Drain-source breakdown voltage

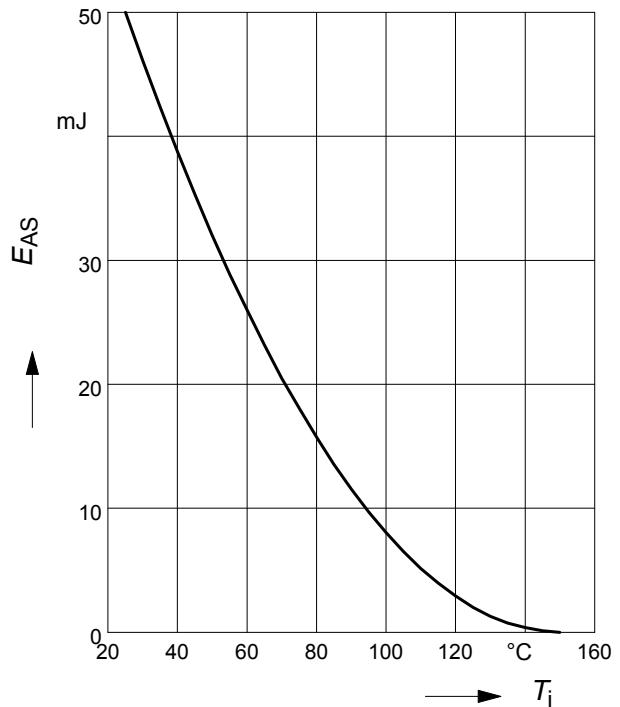
$$V_{(\text{BR})\text{DSS}} = f(T_j)$$



### 18 Avalanche energy

$$E_{AS} = f(T_j)$$

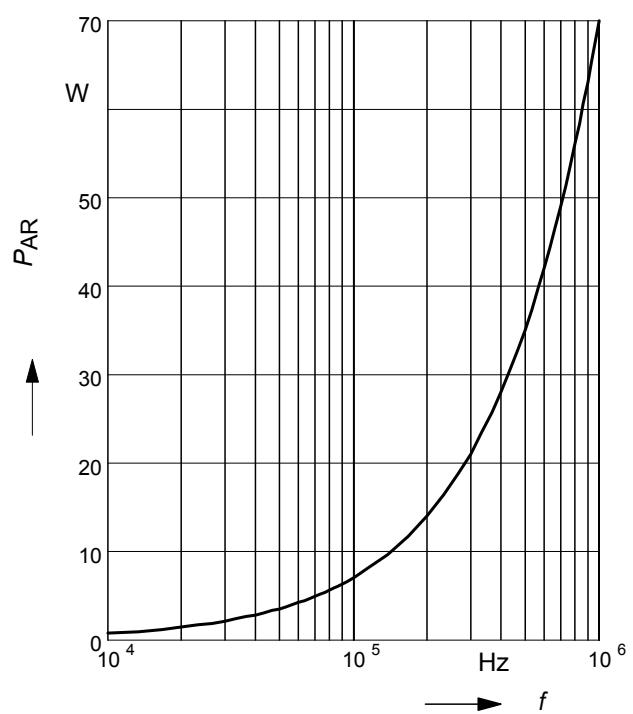
par.:  $I_D = 1.35 \text{ A}$ ,  $V_{DD} = 50 \text{ V}$



### 20 Avalanche power losses

$$P_{AR} = f(f)$$

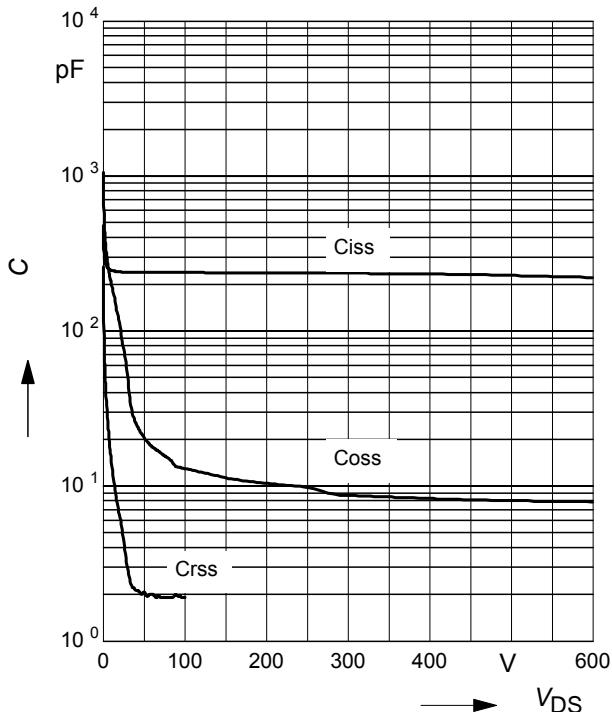
parameter:  $E_{AR}=0.07\text{mJ}$



## 21 Typ. capacitances

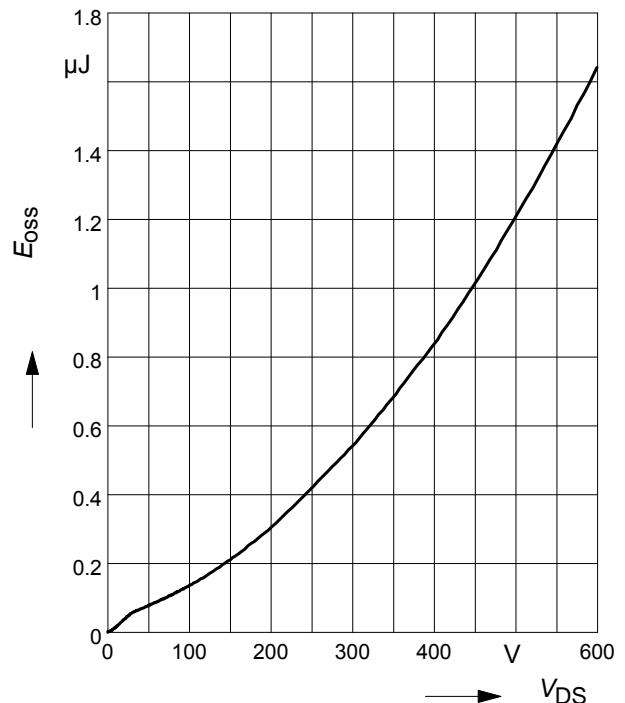
$$C = f(V_{DS})$$

parameter:  $V_{GS}=0V$ ,  $f=1\text{ MHz}$

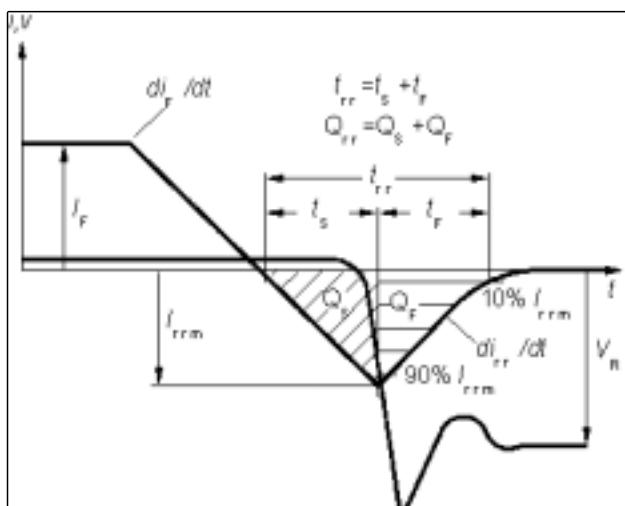


## 22 Typ. $C_{OSS}$ stored energy

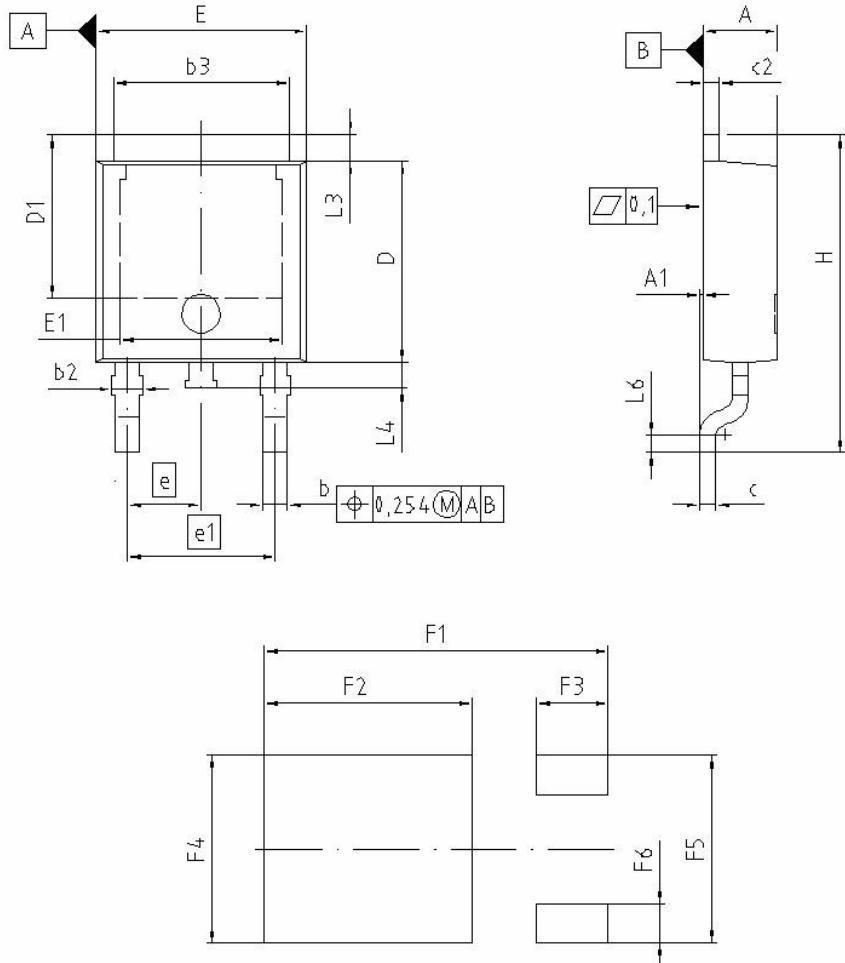
$$E_{OSS} = f(V_{DS})$$



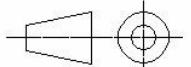
## Definition of diodes switching characteristics



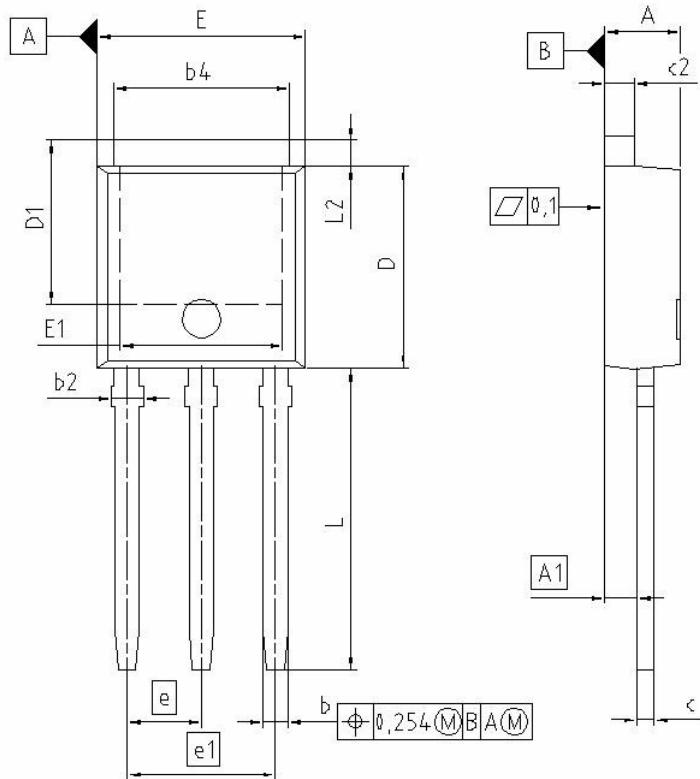
PG-TO-252-3-1 (D-PAK), PG-TO-252-3-11 (D-PAK), PG-TO-252-3-21 (D-PAK)



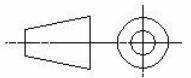
DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
<b>A</b>	2.159	2.413	0.085	0.095
<b>A1</b>	0.000	0.150	0.000	0.006
<b>b</b>	0.635	0.889	0.025	0.035
<b>b2</b>	0.650	1.150	0.026	0.045
<b>b3</b>	5.004	5.500	0.197	0.217
<b>c</b>	0.457	0.580	0.018	0.023
<b>c2</b>	0.460	0.980	0.018	0.039
<b>D</b>	5.969	6.223	0.235	0.245
<b>D1</b>	5.020	5.842	0.198	0.230
<b>E</b>	6.400	6.731	0.252	0.265
<b>E1</b>	4.850	5.207	0.191	0.205
<b>e</b>	2.286		0.090	
<b>e1</b>	4.572		0.180	
<b>N</b>	3		3	
<b>H</b>	9.400	10.480	0.370	0.413
<b>L3</b>	0.900	1.143	0.035	0.045
<b>L4</b>	0.584	0.950	0.023	0.037
<b>L6</b>	0.510	0.686	0.020	0.027
<b>F1</b>	10.500	10.700	0.413	0.421
<b>F2</b>	6.300	6.500	0.248	0.256
<b>F3</b>	2.100	2.300	0.083	0.091
<b>F4</b>	5.700	5.900	0.224	0.232
<b>F5</b>	5.660	5.860	0.222	0.231
<b>F6</b>	1.100	1.300	0.043	0.051

<b>REFERENCE</b>	
JEDEC TO252	
<b>SCALE</b>	0
	2.0
0	2.0
4mm	
<b>EUROPEAN PROJECTION</b>	
	
<b>ISSUE DATE</b>	
21-09-2005	
<b>FILE</b>	
TO252_1	

PG-T0-251-3-1 (I-PAK), PG-T0-251-3-21 (I-PAK)



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.159	2.413	0.085	0.095
A1	0.900	1.118	0.035	0.044
b	0.650	0.850	0.026	0.033
b2	0.650	1.150	0.026	0.045
b4	5.004	5.500	0.197	0.217
c	0.457	0.580	0.018	0.023
c2	0.737	0.980	0.029	0.039
D	5.969	6.223	0.235	0.245
D1	5.100	6.121	0.201	0.241
E	6.400	6.731	0.252	0.265
E1	4.850	5.207	0.191	0.205
e	2.280		0.090	
e1	4.570		0.180	
N	3		3	
L	8.900	9.525	0.350	0.375
L1	0.900	1.143	0.035	0.045

REFERENCE JEDEC TO251
SCALE
0 2.0 0 2.0 4mm
EUROPEAN PROJECTION

ISSUE DATE 20-07-2005
FILE T0251_1



**SPD02N60C3  
SPU02N60C3**

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